Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | AGGARWAL ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
Ö	Α	US-2002/0049044 A1	04-2002	Indseth, Hakon	455/118
	В	US-6,185,434 B1	02-2001	Hagstrom et al.	455/552.1
	С	US-6,002,860 A	12-1999	Voinigescu et al.	703/14
	D	US-5,740,524 A	04-1998	Pace et al.	455/232.1
	Е	US-5,448,602 A	09-1995	Ohmori et al.	375/347
	F	US-5,079,556	01-1992	Itoh, Shin-Ichi	342/109
	G	US-6,628,176 B1	09-2003	Okada, Tohru	333/32
	Н	US-			
	ı	US-			
	J	US-			,
	К	US-			,
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.